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Current-phase relations of InAs nanowire Josephson junctions: From interacting to multimode regimes

Sean Hart,^{1,2,*} Zheng Cui,^{1,2,3,*} Gerbold Ménard,⁴ Mingtang Deng,⁴ Andrey E. Antipov,⁵ Roman M. Lutchyn,⁵
Peter Krogstrup,^{4,6} Charles M. Marcus,⁴ and Kathryn A. Moler^{1,2,3}

¹Stanford Institute for Materials and Energy Sciences, SLAC National Accelerator Laboratory, Menlo Park, California 94025, USA

²Geballe Laboratory for Advanced Materials, Stanford University, Stanford, California 94305, USA

³Department of Applied Physics, Stanford University, Stanford, California 94305, USA

⁴Center for Quantum Devices and Microsoft Quantum Lab-Copenhagen, Niels Bohr Institute, University of Copenhagen, 2100 Copenhagen, Denmark

⁵Station Q, Microsoft Research, Santa Barbara, California 93106-6105, USA

⁶Microsoft Quantum Materials Lab, Niels Bohr Institute, University of Copenhagen, 2800 Kongens Lyngby, Denmark



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Gate-tunable semiconductor-superconductor nanowires with superconducting leads form exotic Josephson junctions that are a highly desirable platform for two types of qubits: Those with topological superconductivity (Majorana qubits) and those based on tunable anharmonicity (gatemon qubits). Controlling their behavior, however, requires understanding their electrostatic environment and electronic structure. Here we study gated InAs nanowires with epitaxial aluminum shells. By measuring current-phase relations and comparing them with analytical and numerical calculations, we show that we can tune the number of modes, determine the transparency of each mode, and tune into regimes in which electron-electron interactions are apparent, indicating the presence of a quantum dot. To take into account electrostatic and geometrical effects, we perform microscopic self-consistent Schrodinger-Poisson numerical simulations, revealing the energy spectrum of Andreev states in the junction as well as their spatial distribution. Our work systematically demonstrates the effect of device geometry, gate voltage, and phase bias on mode behavior, providing insights into ongoing experimental efforts and predictive device design.

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I. INTRODUCTION

Studies of hybrid structures of superconductors and semiconducting nanowires have recently spurred advances in fundamental physics, materials science, and technology [1]. A growing body of experimental evidence supports proposals that nanowire-superconductor hybrids can host Majorana modes, the building blocks in schemes for topological quantum computing [2–13]. Gate-tunable nanowire Josephson junctions have also been integrated into a cavity-QED architecture, providing electrostatic control of the qubit transition frequency [14,15]. Improving the design and operation of these devices will rely on understanding their electrostatic environment and electronic structure, with several recent works examining mode behavior in wire devices [16–21]. Moreover, electron-electron interactions, often overlooked in both experiment and theory, should also be considered as they are expected to play an important role, particularly in one or fewer dimensions.

Here we report measurements of the current-phase relation (CPR) of a Josephson junction based on an InAs nanowire, carried out using a scanning superconducting quantum interference device (SQUID) microscope. The amplitude and phase dependence of the CPR are sensitive to the transparency

and number of modes contributing to supercurrent in the junction [17,22–25]. Microscopic regimes with one or multiple modes can be distinguished through comparison to a simple analytic model, by a model-independent analysis, and by comparison to numerical simulations. The qualitative agreement of the current-phase relations between our simulations and experiment enables the use of numerical modeling for visualizing the microscopic effect of electrostatic gating. In the regime of low electron density in the junction, we find evidence of interactions which modify both the spectrum and the phase dependence of current flow in the device (i.e., lead to a sign reversal of the supercurrent). Our simulation of the device behavior, combined with our understanding and control of both interactions and anharmonicity, provides insight into recent experiments and allows for more deterministic device design.

II. MEASURING THE CURRENT-PHASE RELATION OF AN InAs NANOWIRE JOSEPHSON JUNCTION

To investigate the CPR of the InAs nanowire Josephson junction, we fabricated a superconducting ring consisting of a 100-nm-thick annular film of evaporated aluminum bridged by a hybrid epitaxial aluminum-InAs nanowire [Fig. 1(a)]. The Josephson junction is located at the center of the nanowire. To measure the current-phase relation, we positioned the pickup loop and field coil of a SQUID microscope

*These authors contributed equally to this work.

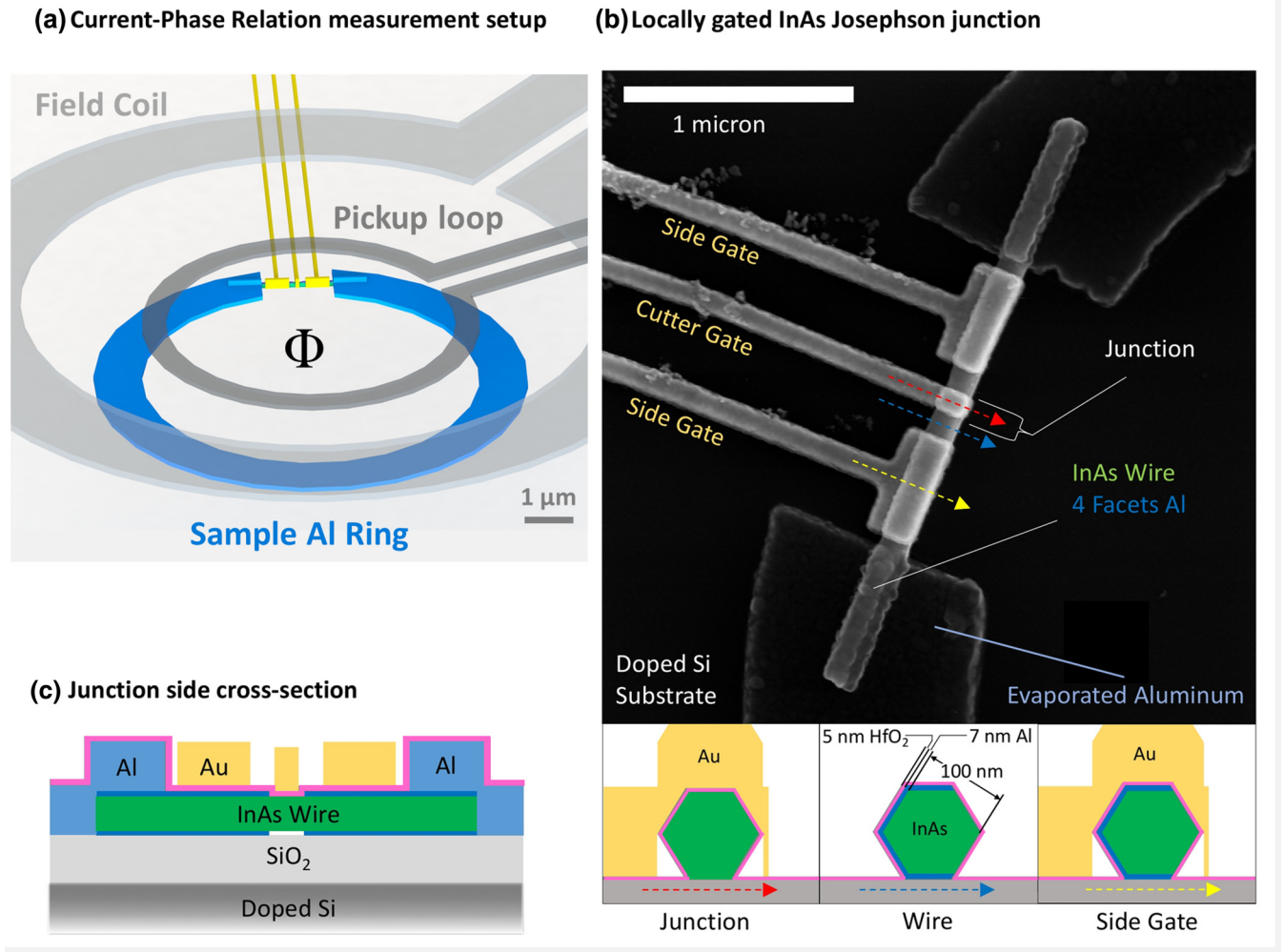


FIG. 1. Experimental setup to measure the current-phase relation of an InAs nanowire-based Josephson junction. (a) The sample ring consists of an evaporated aluminum ring (blue), which is interrupted by an InAs nanowire (green with yellow gates) to form a Josephson junction. To measure the current-phase relation of the junction, the sensing head of a SQUID microscope is positioned above the sample ring. A current bias applied to the field coil (light gray) tunes the magnetic flux through the sample ring, providing control of the phase difference across the junction. This phase difference determines the supercurrent in the junction via its current-phase relation. The supercurrent circulates in the sample ring, leading to a signal which is measured by the pickup loop (dark gray). Drawing is to scale. (b) A scanning electron micrograph depicts a top view of the portion of the sample ring spanned by the InAs nanowire. As depicted in the bottom panels, the nanowire has a hexagonal cross section and is coated epitaxially on four facets with a 7-nm layer of aluminum (blue). This epitaxial aluminum layer is chemically removed along a 100-nm span beneath the cutter gate, while the wire is isolated from the gate with a 5-nm layer of HfO_2 (pink), shown in bottom left cross section. The center and right cross sections indicate the structure of the wire in ungated sections and in sections with a side gate. The respective locations of the cross sections are labeled by red, blue, and yellow arrows on the SEM image. (c) A cross-sectional side view of the wire shows the layer structure of the device. The sample ring rests on a doped silicon substrate, providing the ability to gate the device globally from below.

approximately 1 μm above the sample ring [26]. When a current is applied to the field coil, a magnetic flux Φ is generated in the sample ring. This flux directly tunes the phase difference ϕ across the nanowire junction, leading to a supercurrent in the junction due to its current-phase relation. The supercurrent circulates in the sample ring and is measured as a flux in the pickup loop [23,24,27]. The center position of the ring can be found with submicron precision by the diamagnetic response from the ring. By modeling the SQUID-sample geometry and calibrating the mutual inductance against the periodicity of the current-phase relation, we convert the flux signal into a Josephson supercurrent in the ring [28]. The

mutual inductance can change up to 5% over long periods of time due to drift in the SQUID position. Since we calibrate the mutual inductance for each CPR measurement, our analysis is not affected by this drift.

The hybrid nanowires are grown by molecular beam epitaxy [29]. Au-catalyzed InAs nanowires are first grown via the vapor-liquid-solid method, followed by a low-temperature *in situ* growth step of 7 nm of aluminum on four of the six side facets [Fig. 1(b)]. The four-facet coverage is realized in two steps of two-facet growth with an intermediate 120° rotation of the nanowire orientation with respect to the atomic aluminum beam, which ensures a flat, continuous aluminum

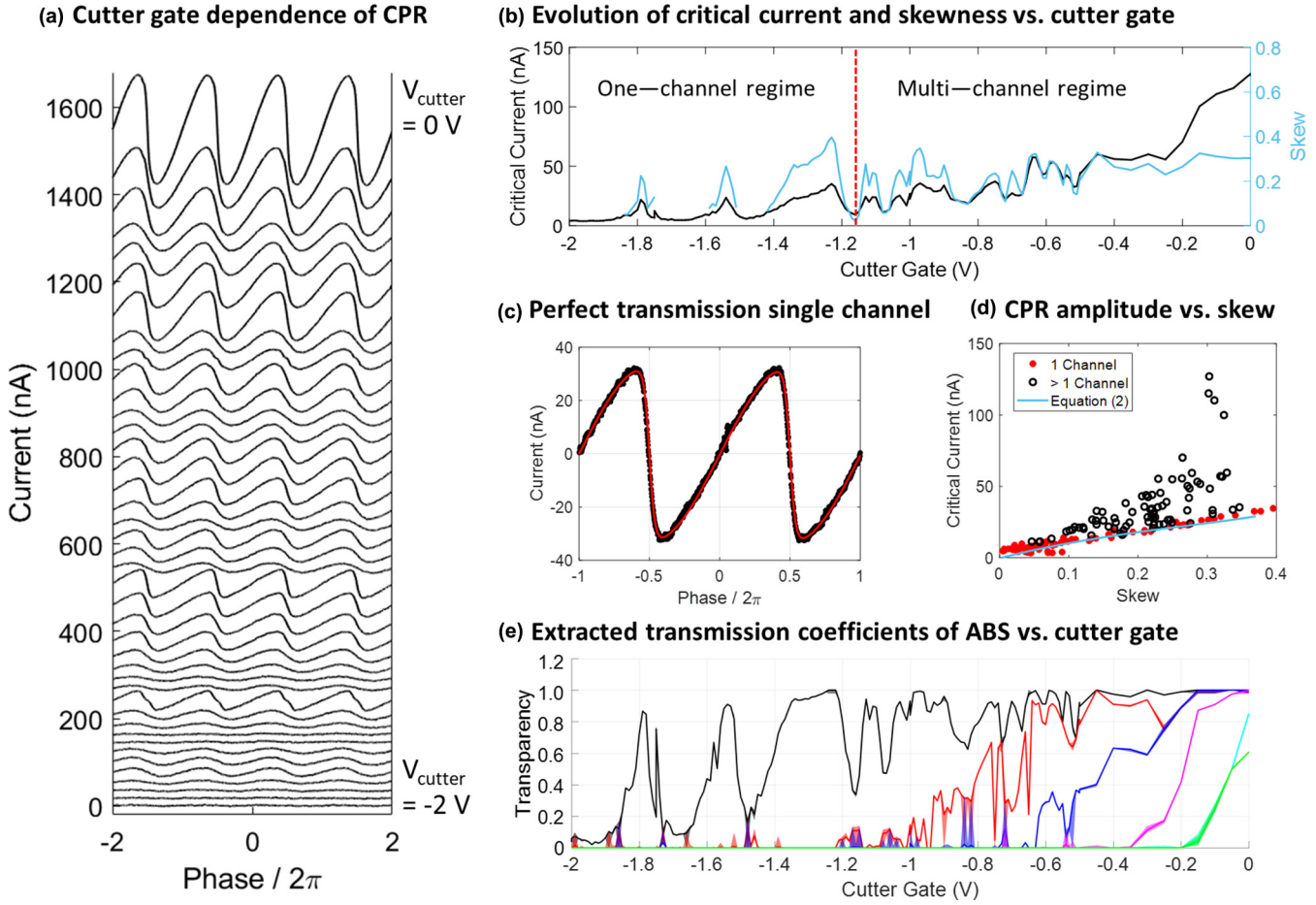


FIG. 2. CPR measurements probe the evolution of supercurrent-carrying modes with gate voltage. (a) The amplitude and shape of the CPR evolve as the voltage applied to the cutter gate decreases from 0 to -2 V, corresponding to changes in the structure of the Andreev bound states as a function of applied electric field. Each curve is a measured current-phase relation at a particular cutter gate voltage. The waterfall plot represents an evenly spaced subset of the gate sweep and is offset vertically for clarity. (b) The dependence of CPR amplitude and shape on cutter gate voltage. The black curve shows the critical current amplitude (left y axis) vs gate voltage. The light blue curve shows CPR skew vs gate voltage (right y axis). The skew is calculated as the ratio between the second and first harmonics (i.e., Fourier component) of the CPR, $S = -\frac{A_2}{A_1}$. Recurring peaks at $V_C < -1.16$ V (red dashed line) signified resonant tunneling in the single-channel regime. (c) Fitting CPR data at $V_C = -1.22$ V (black dots) to Eq. (2) (red line) results in a single channel with $\tau = 1$, $T = 98$ mK, and $\Delta = 128 \mu\text{eV}$. (d) Scatterplot of CPR amplitude vs skew for all measured cutter gate voltages between 0 and -2 V reveals distinct regimes. Red dots are taken from $V_C < -1.16$ V, showing highly correlated amplitude and skew expected from a single channel. The blue curve is the expected single-channel behavior calculated from Eq. (2) (with $T = 98$ mK and $\Delta = 128 \mu\text{eV}$). (e) Extracted transmission coefficients of ABS vs. cutter gate. Different colors are only for visual clarity and are not meant to differentiate physical states. The vertical width of shaded regions represents the 68% confidence interval of the fitted parameters.

film on all four facets. This epitaxial aluminum makes electrical contact with the evaporated aluminum film to close the ring. In the center of the nanowire, the epitaxial aluminum is chemically removed over a span of 100–150 nm to form the junction. The junction lies under a Ti/Au “cutter” gate, while two additional side gates overlap the wire in regions still contacted with epitaxial aluminum [see Fig. 1(c)]. A 5-nm layer of HfO_2 (shown in pink) isolates the gates and the wire. The side gates are expected to be mostly screened by aluminum but can still affect the wire via fringe electric fields. Finally, the sample ring sits on a doped silicon substrate capped with a thin layer of oxide, allowing the wire to be gated from below. We found that the cutter gate and back gate have qualitatively similar effects, indicating that both

gates primarily affect the same junction region (under the cutter gate) due to screening from the epitaxial aluminum [28]. Hence, we focus mainly on the modulation of the CPR by the cutter gate and side gates.

III. MODEL-INDEPENDENT ANALYSIS OF CURRENT-PHASE RELATION VERSUS CUTTER GATE VOLTAGE

To explore the effect of local gating on the nanowire junction, we measured the CPR at a series of voltages V_C applied to the cutter gate [Fig. 2(a)]. As the cutter gate voltage is tuned from -2 to 0 V, the amplitude of the CPR evolves through several qualitatively distinct regimes. At the most

negative gate voltages, the onset of supercurrent gives way to a set of recurring peaks in the critical current [plotted in black in Fig. 2(b)]. As the gate voltage increases above $V_C \approx -1.16$ V, the critical current begins to fluctuate with gate voltage. Finally, above $V_C \approx -0.45$ V, the fluctuations diminish, and the critical current begins to increase more steeply with gate voltage.

These gate-dependent features of the junction's critical current are accompanied by strong variations in the phase dependence, or shape, of the CPR [visible in Fig. 2(a)]. The most prominent feature of these shape variations is their forward skew, meaning that the critical current occurs at an advanced phase compared to a sine wave. The skew of a CPR can be characterized by taking its Fourier transform and defining a quantity $S = -A_2/A_1$, where A_1 and A_2 are the first and second harmonics of the CPR. Positive S indicates forward skew, and hereafter, we use S and “skew” interchangeably.

Plotting the skew on the same gate voltage axis as the critical current reveals an intricate interplay between the shape of the CPR and its amplitude [light blue in Fig. 2(b)]. At the most negative gate voltages, recurring peaks in the critical current are accompanied by coincident peaks in the skew. In the intermediate regime of fluctuating critical current, the skew also fluctuates, and some correlations are observable between critical current and skew. As the critical current begins to increase sharply at the most positive gate voltages, the skew remains relatively constant near $S = 0.3$. Throughout the gate trace, it is remarkable that the CPR is almost always forward skewed ($S > 0$), in sharp contrast to the sinusoidal behavior ($S = 0$) found in the conventional Josephson effect. At certain gate voltages, the skew is not calculated due to the CPR amplitude being too small to obtain a reliable result.

Figure 2(d) more clearly distinguishes the different regimes mentioned above. For $V_C < -1.16$ V, the CPR shows highly correlated amplitude and skew (red dots), distinct from $V_C > -1.16$ V. Next, by comparing the relationship between amplitude and skew to a well-known theoretical model, we quantitatively identify these distinct regimes as having different numbers of supercurrent-carrying modes.

IV. SHORT-JUNCTION THEORY REVEALS MODE NUMBER AND TRANSPARENCY

The variations of the CPR amplitude and shape with gate voltage contain considerable information about the electronic structure of the junction. The CPR depends on the electronic properties of the junction according to the fundamental relation

$$I(\phi) = \frac{2e}{\hbar} \frac{dF}{d\phi}, \quad (1)$$

where F is the free energy and ϕ is the phase difference across the Josephson junction [30]. In the limit where the junction length is short compared to the superconducting coherence length, the dominant contribution to the supercurrent comes from discrete spectrum of bound states in the junction, with energies $\epsilon_p = \Delta\sqrt{1 - \tau_p \sin^2(\phi/2)}$ [25]. The energies ϵ_p of these states, called Andreev bound states, are related to the transmission probabilities τ_p of the underlying normal conduction channels in the junction. Here Δ is the amplitude of

the Andreev states, and in the short-junction limit it is equal to the superconducting gap. With this spectrum, Eq. (1) can be simplified to a well-known formula [31–33]:

$$I(\phi) = -\frac{2e}{\hbar} \sum_{p=1}^N \frac{d\epsilon_p}{d\phi} \tanh\left(\frac{\epsilon_p}{2k_B T}\right) \\ = \frac{e\Delta^2}{2\hbar} \sin\phi \sum_{p=1}^N \frac{\tau_p}{\epsilon_p} \tanh\left(\frac{\epsilon_p}{2k_B T}\right). \quad (2)$$

Here N corresponds to the number of Andreev bound states in the junction.

This simplified model illustrates that the CPR is a sensitive probe of both the number of modes and their transparencies τ_p . In the simplest case of a single channel, the amplitude and skew of the CPR both increase with τ_1 . In a state with low transparency ($\tau_1 \ll 1$), a sinusoidal CPR is expected ($S \rightarrow 0$). In a state with high transparency ($\tau_1 \sim 1$), the CPR is forward skewed ($S > 0$), up to the limit of $S = 0.4$ for $T = 0$ K and $\tau_1 = 1$. When more than one channel contributes to the CPR, the shape and amplitude of the CPR become sensitive to a set of $N > 1$ transmission probabilities.

First, we performed fits to Eq. (2) with a highly forward skewed CPR at $V_C = -1.22$ V, with free parameters $\{\Delta, T, \tau_1, \tau_2, \dots\}$. The best fit result is shown in Fig. 2(c), with $\Delta = 128 \mu\text{eV}$, $T = 98$ mK, $\tau_1 = 1$, and $\tau_p = 0$ for $p > 1$ [28]. The nominal sample stage temperature is ~ 60 mK. Although the fitted effective temperature is slightly elevated, we are still in the regime of $T \ll T_c$ and thus should be free from any noise-induced quasiparticle excitation that could affect the CPR. All wires connected to both the sample and the scanning SQUID are filtered by rf filters with at least 45-dB attenuation above 10 MHz [34]. The extracted amplitude parameter $\Delta = 128 \mu\text{eV}$ is the energy of Andreev states at zero phase bias. The comparison between this value and the proximity-induced gap reported in normal-superconducting transport experiments for similar epitaxial-Al-covered InAs nanowires [12] is presented in Sec. VII. Systematic experimental uncertainty is also considered in [28].

We subsequently performed fits of Eq. (2) to the CPR data (with $\Delta = 128 \mu\text{eV}$ and $T = 98$ mK held constant), allowing up to $N = 6$ contributing modes. The best fit result is summarized in Fig. 2(e). Below $V_C \approx -1.16$ V, the CPR is well described by a single contributing channel. This perfectly coincides with the single-channel regime identified by our model-independent analysis earlier [in Figs. 2(b) and 2(d)].

Throughout the regime of fluctuating critical current, $V_C \approx -1.16$ V to $V_C \approx -0.45$ V, a second and third channel can be seen to contribute [Fig. 2(e), red and blue]. Although their respective transparencies fluctuate strongly, the number of channels nevertheless increases monotonically with increasing gate voltage, agreeing with the intuition of gate tuning the number of occupied electron states in the junction. This regime is also characterized by random scatters of CPR amplitude vs skew, with little correlation.

Above $V_C \approx -0.45$ V, additional channels enter with transmission coefficients approaching unity rapidly with gate voltage. This regime is characterized by consistently forward

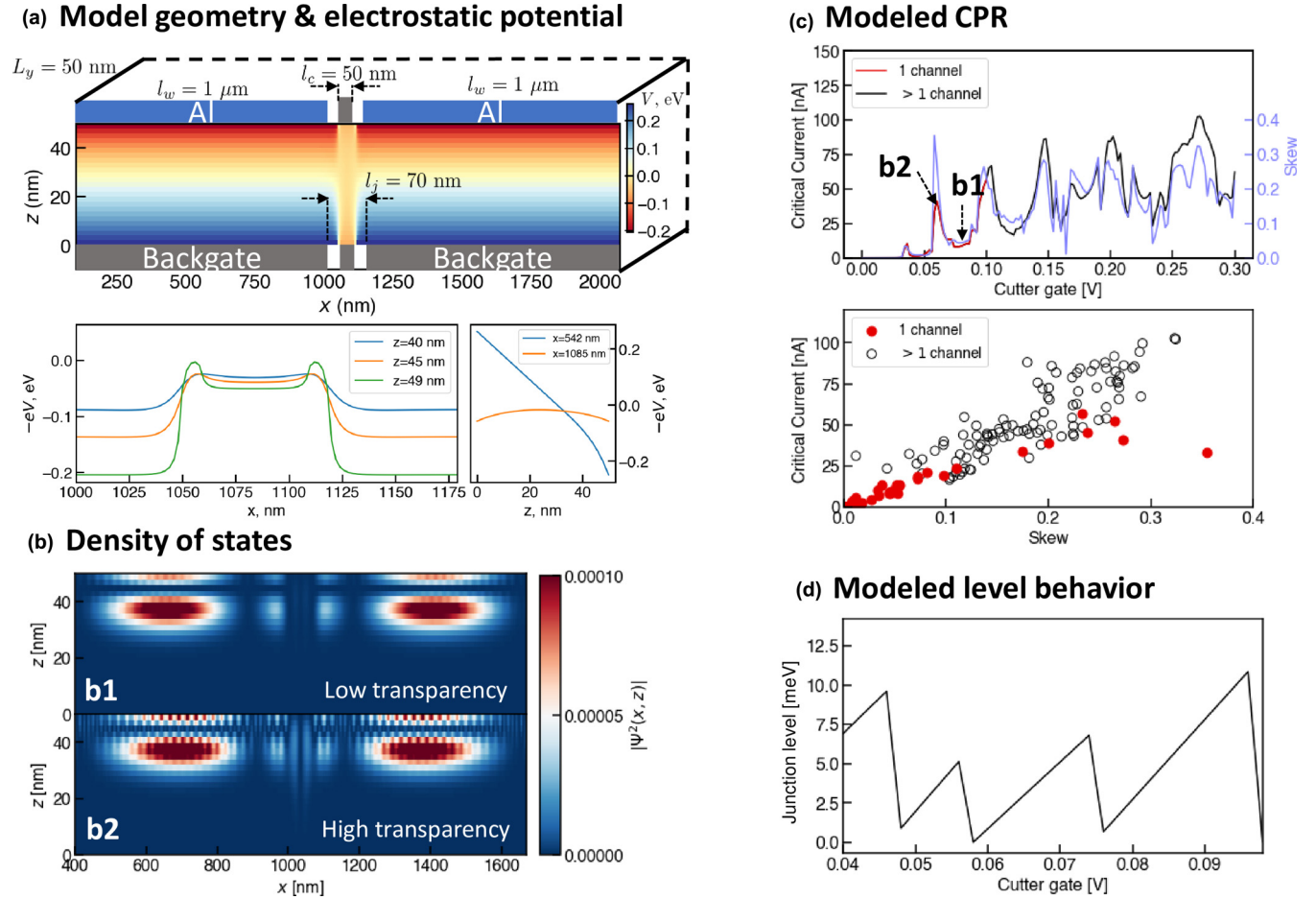


FIG. 3. Numerical simulations of the InAs junction. (a) Top: Schematics of the simulated model, consisting of two wire segments and the junction, each augmented with an electric gate. Empty spaces at the interface of the wire and vacuum in the junction indicate the zero boundary value of potential. Color indicates the calculated electrostatic potential for the left/right gate voltage of -0.29 V and cutter voltage of 0.06 V. Bottom: Two-dimensional cuts of the electrostatic potential along the x direction (left) and along the z direction (right). (b) The density of the lowest positive Andreev state at phase $\phi = \pi$ in the junction at a cutter voltage of (b1) 0.07 V and (b2) 0.06 V, corresponding to the regimes of low and high transparency in the junction, respectively. The color scale shows the probability density calculated as the square of the wave function amplitude. (c) Top: Calculated dependence of the critical current (red and black) and skew (blue) on the cutter gate voltage. Arrows indicate the gate voltages of (b1) and (b2). Bottom: The dependence of the calculated critical current on the skew. In both panels red indicates the single-channel regime. (d) The dependence of the position of the highest occupied level in the junction on the cutter gate voltage.

skewed CPR ($S \sim 0.3$) and monotonically increasing critical current amplitude with gate voltage.

V. USING NUMERICAL SIMULATIONS TO STUDY THE INTERPLAY OF ELECTROSTATIC POTENTIAL, SPATIAL STRUCTURE, AND THE SPECTRUM OF ANDREEV STATES

Although the short-junction model provides an intuitive description of the number and transparency of modes in the junction, it is limited in its ability to faithfully represent device behavior. In a real device, the spectrum and spatial distribution of states will be influenced by the device geometry, material composition, and details of the electrostatic potential [35–37]. Understanding these effects is important for device engineering in qubit and Majorana applications, motivating a more detailed model of the observed CPR.

We study a microscopic model of the system, consisting of two wires and a junction, with the geometry shown in

Fig. 3(a). The wire's state is controlled by three electric gates: Two below the wires and the cutter gate in the junction. In the normal state it is described by the following low-energy Hamiltonian:

$$\hat{H}_n = \frac{1}{2m^*} (\hat{k}_x^2 + \hat{k}_y^2 + \hat{k}_z^2) + V(x, z) - \alpha (\hat{k}_x \sigma_y - \hat{k}_y \sigma_x), \quad (3)$$

where operators $\hat{k}_{x,y,z}$ denote the momentum in the x, y, z directions, $\sigma_{x,y,z}$ are Pauli matrices, $m^* = 0.026m_e$ [1] is the effective mass in InAs (m_e is the electron mass), $\alpha = 0.01$ eV nm is the spin-orbit coupling [1], and V is the electrostatic potential, created by the electric gates. The potential is translationally invariant along the y direction and can be calculated by solving the Poisson equation $\nabla^2 V(x, z) = -\frac{en(x, z)}{\epsilon_0 \epsilon_r}$, with $\epsilon_r = 15.2$ and the boundary conditions set by the voltages of the surrounding gates and the band offset at the interface of InAs and Al, which we take as $W = 0.25$ eV. Boundary conditions between the wire and vacuum in the junction region are set to zero to model a well with a resonant

character of current transmission through the junction, as observed in Fig. 2(e). In order to obtain the potential one has to self-consistently determine the density of electrons and the potential in a Schrodinger-Poisson loop, which is computationally prohibitive. Instead, we employ the Thomas-Fermi approximation for the density $n = \frac{1}{3\pi^2} \left(\frac{2m^*\phi}{\hbar^2} \right)^{3/2}$, which produces excellent agreement for the potential with the full Schrodinger-Poisson method [35,38].

Superconductivity is included using a Bogoliubov-de Gennes Hamiltonian and adding pairing potentials Δ and $\Delta e^{i\phi}$ to the left and right proximitized segments of the wires, respectively, leading to the phase difference ϕ across the junction. The numerical complexity is alleviated by projecting the Hamiltonian in the y direction to the basis of sinusoidal eigenstates [35,39].

The zero-temperature CPR is calculated from the Andreev spectrum by taking the derivative of the ground-state energy with respect to ϕ [see Eq. (1)] [40]. The gate dependence of the simulated critical current is shown in the top panel of Fig. 3(c) (black) and is qualitatively similar to the experimental data. As the gate voltage increases, an insulating regime transitions into three well-separated peaks, which then evolve into a regime of fluctuating critical current. Within the regime of recurring peaks, the simulated supercurrent is dominated by the contribution from a single mode. The well-separated peaks in the Josephson current are indicative of tunneling through resonant levels in the junction [25]. The skew of the modeled CPR tends to increase and decrease with the critical current [light blue in Fig. 3(c)]. Plotting the simulated skews and critical currents against one another reveals that this relationship strongly resembles the experiment [bottom panel in Fig. 3(c)]. The simulated behavior with only one contributing mode, plotted in red, shows strong correlation between critical current and skew. These single-channel points lie predominantly along the bottom part of the scatterplot, as found experimentally.

The excellent agreement between the measured and simulated CPRs provides an opportunity to further examine the electronic structure of the device. In Fig. 3(b), the local density of states in the single-channel regime reveals a striking difference in the structure of low- and high-transparency states [also indicated by black arrows in Fig. 3(c)]. In both cases the band offset between aluminum and InAs leads to an enhanced density of states in the nanowire near the aluminum coating. At high transparency ($\tau \approx 0.98$), the density of states becomes much larger in the junction than that at low transparency ($\tau \approx 0.32$). The change between regimes occurs in the range of 10 mV difference in V_C , indicating the delicate nature of the quantum states in the junctions formed by InAs nanowires.

Figure 3(d) shows the evolution with cutter gate voltage of the highest occupied level energy in the junction, where zero energy corresponds to the chemical potential of the leads. This simulation demonstrates that sweeping the cutter gate voltage can be expected to bring a series of states in and out of resonance with the leads. In particular, the vertical jumps indicate that the resonant-level spacings ΔE are of the order of a few meV. This $\Delta E \gg \Delta_{SC}$ (where Δ_{SC} is the superconducting gap of the leads) gives rise to multiple

resonance peaks in the single-channel regime. As further proof of resonant tunneling behavior, the level energy minima near $V_C = 0.058$ V and $V_C = 0.1$ V coincide with the Fermi energy of the leads ($E = 0$) and at the same time correspond precisely to the first two supercurrent peaks in Fig. 3(c). All other energies in Fig. 3(d) are far from $E = 0$ and correspond to suppressed supercurrent in Fig. 3(c).

VI. INTERACTING BEHAVIOR IN THE SINGLE-MODE PEAKED REGIME

We now focus on the single-channel regime to investigate in more detail the series of recurring peaks in critical current [Fig. 4(a)]. When the cutter gate voltage V_C is tuned away from the peaks, the CPR is consistent with noninteracting short-junction theory. Near two of these peaks, however, the CPR deviates from the noninteracting behavior and instead displays a shoulder near phase $\phi = \pi$ [Fig. 4(b)]. The shoulder features are a precursor to π -junction behavior resulting from the Coulomb blockade effect [41–49] and have been studied experimentally in a carbon nanotube Josephson junction [50]. Related phenomena have also been observed in nanowire-superconductor hybrids [17,51–54], but without quantitative modeling of the CPR.

To understand the shoulder behavior in the CPR, we consider a scenario where a quantum dot (QD) is formed in the junction. The QD is characterized by the strength of the local Coulomb electron-electron interaction U and a single spin-degenerate level with energy ξ measured relative to the chemical potential of the leads [see Fig. 4(c)]. Coupling strengths to the right/left leads $\Gamma_{R/L}$ and the energy ξ depend on the cutter gate voltage. Following Ref. [43], we treat interactions within the mean-field approximation and introduce a local exchange field $J = U(\langle n_\downarrow \rangle - \langle n_\uparrow \rangle)/2$, where $\langle n_{\uparrow/\downarrow} \rangle$ are single-level occupation probabilities for spin-up and spin-down electrons. In the limit when $\Gamma_R = \Gamma_L = \Gamma \gg \Delta$, the resulting Andreev energies can be obtained analytically:

$$\epsilon_{\pm} = \Delta \sqrt{\frac{\cos^2 \phi/2 + 2E^2 + Z^2(Z^2 + \sin^2 \phi/2) \pm 2XS(\phi)}{Z^4 + 2(X^2 + E^2) + 1}}. \quad (4)$$

Here ϕ is the phase difference $\phi_L - \phi_R$ between the left and right leads, $S(\phi) = \sqrt{Z^2 \cos^2 \phi/2 + E^2 + (\sin^2 \phi)/4}$, $E = \xi/2\Gamma$, $X = J/2\Gamma$, and $Z^2 = X^2 - E^2$. With the above formula for the Andreev spectrum, we have the following expression for the current-phase relation:

$$I(\phi) = -\frac{e}{\hbar} \left[\tanh \left(\frac{\epsilon_+}{2k_B T} \right) \frac{d\epsilon_+}{d\phi} + \tanh \left(\frac{\epsilon_-}{2k_B T} \right) \frac{d\epsilon_-}{d\phi} \right]. \quad (5)$$

In this model, the expected junction behavior results from an interplay between the level energy ξ and the on-site exchange coupling J . The characteristic peaks in the supercurrent observed in the experiment [see Fig. 4(a)] are related to the charge-degeneracy points. We now analyze the CPR using the simple model above and consider the $\xi/\Gamma = 0$ case. Without interactions, such a situation corresponds to a resonant transmission through the QD, with the CPR given by the red line in Fig. 4(d). The exchange interactions effectively

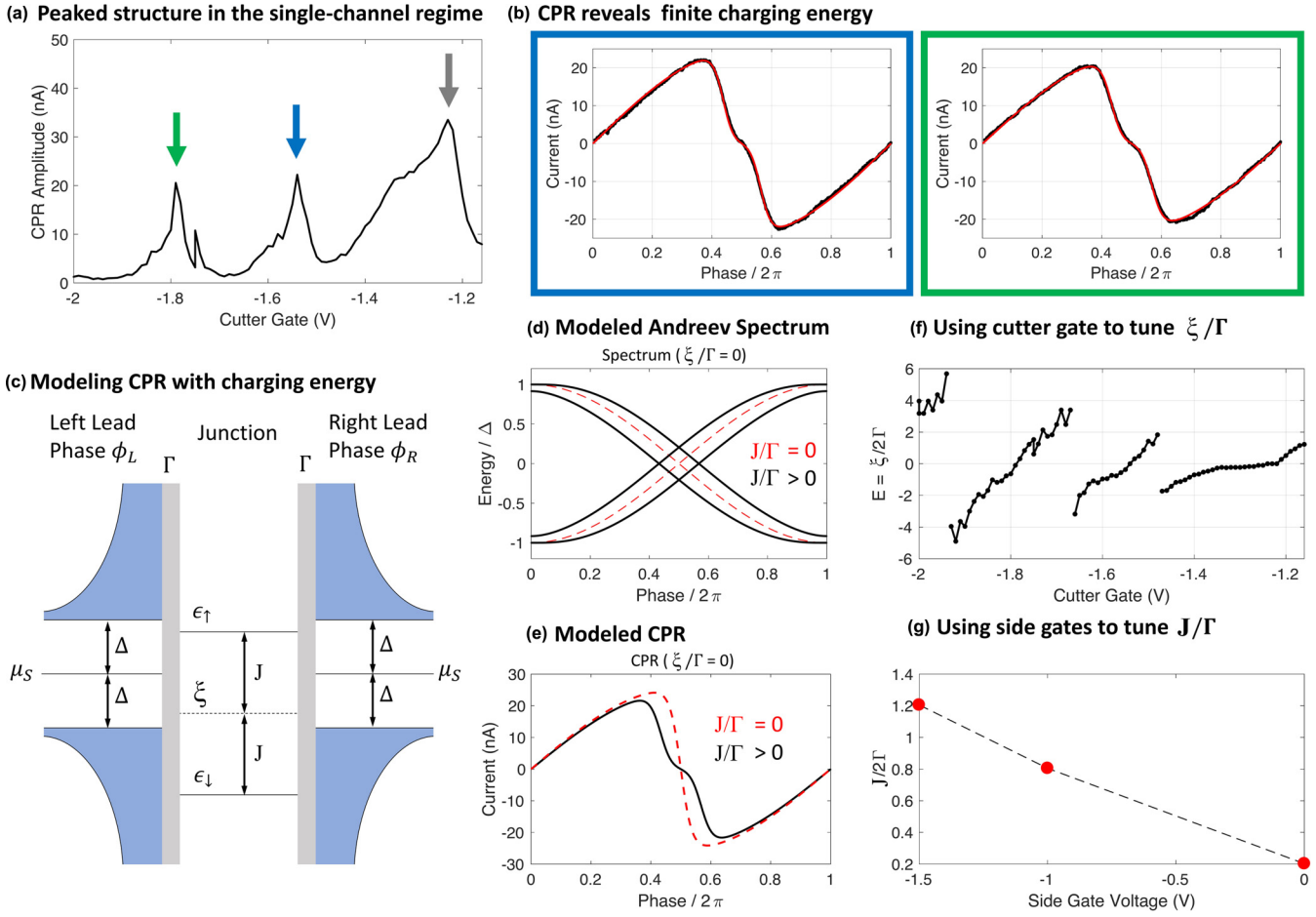


FIG. 4. Using the CPR to elucidate the role of interactions in the single-channel regime. (a) In the single-channel regime, the CPR amplitude develops recurring peaks, indicated by arrows. (b) At two of these peaks, a shoulder appears in the CPR near phases equal to π modulo 2π . The colored borders surrounding the plots correspond to colored arrows in (a). The appearance of the shoulders in the CPR is evidence of finite charging energy in the junction region of the device. (c) Modeling our device with finite charging energy allows calculation of CPRs in this regime. The two leads, with gap Δ and chemical potential μ_s , are coupled to the junction symmetrically with coupling Γ . The charging energy is modeled as an exchange energy J in the device, which splits a state at energy ξ in the junction into odd- and even-parity states with respective energies ϵ_\downarrow and ϵ_\uparrow . (d) and (e) The model allows calculation of the spectrum of Andreev states and the CPR, shown here without charging energy (red dashed lines) and with finite charging energy (black solid lines). The appearance of a shoulder is characteristic of finite charging energy when $\xi/\Gamma \approx 0$ and can be used in fits to the data [red curves in (b)]. (f) Fitting the model to the data throughout the single-channel regime reveals the evolution of energy levels in the device. (g) The model can also be fit to the data at different values of side gate voltage, revealing that more negative side gate voltage corresponds to increased J/Γ .

split the spin-degenerate level, creating level crossings away from $\phi = \pi$ [black curves in Fig. 4(d)]. Using this spectrum, one finds the appearance of a shoulder near $\phi = \pi$ in the CPR. Larger interaction strength leads to level crossings farther away from $\phi = \pi$ and thus wider shoulders in CPR. By fitting the experimental data to Eq. (5), we find good agreement with the measured CPR data, with best-fit values for the interaction strength given by $J/\Gamma = 0.39$ and 0.42 when $V_C = -1.54$ and -1.79 V, respectively [the red curve in Fig. 4(b) is the best fit].

Away from the single-particle resonance (i.e., $\xi \neq 0$), the dispersion of the Andreev states with ϕ gets suppressed due to the reduction in transmission probability through the QD. A nonzero exchange energy splits the Andreev level spin degeneracy as before, but as long as $\xi \gg J$, the levels will not cross at zero energy. Thus, one expects the reversal of

the supercurrent to appear in the CPR only when the junction is tuned near resonance. Indeed, we observe shoulders in the CPR only near peaks in the critical current, consistent with the theoretical predictions.

Fitting the measured CPR to Eq. (5) throughout the single-channel regime allows one to extract the cutter gate dependence of the normalized site energy ξ/Γ [Fig. 4(f)]. As the cutter gate increases from -2 to -1.16 V, three levels are tuned in and out of resonance with the leads. In addition to shifting the spectrum, the cutter gate is expected to modify the shape of the confining potential in the junction and the coupling Γ . We speculate that the coupling Γ may increase with V_C , contributing to the decrease in slopes in Fig. 4(f) as V_C becomes more positive. The experimentally extracted evolution of levels agrees qualitatively with numerical simulations [see Fig. 3(d)].

In the measurements discussed so far, only the cutter gate voltage was varied, with all other gates grounded. With negative voltage V_S applied to the two side gates, we observed additional CPRs with shoulderlike features. Fitting these CPRs to Eq. (5) yielded values for the normalized exchange energy J/Γ . As the side gate voltages become more negative, we find an increase in the mean value of J/Γ at each gate voltage (Fig. 4(g) and [28]). Fringe electric fields at the two ends of the junction may lead to decreased coupling Γ with more negative V_S , consistent with this finding. We observed no shoulderlike features in any CPR with positive side gate voltage.

VII. DISCUSSION

Our fits to the current-phase relationship in Fig. 2 indicate the amplitude of Andreev bound states of $\Delta = 128 \mu\text{eV}$, which is smaller than the proximity-induced gap for similar devices [12]. Unlike conventional metallic Josephson junctions, where a normal region is sandwiched between two superconducting leads, our junction is formed by two semiconducting wire segments with a proximity-induced gap and contains an emergent resonant level. Therefore, the scattering processes that lead to the Andreev bound states involve both normal scattering from the resonant level in the junction to the semiconducting wire segments and Andreev reflections at the interface with the superconductor. The Andreev spectrum here is closely related to that of a resonant level coupled to two superconductors, and the amplitude of the Andreev states in this scenario depends on the coupling of the dot to the wires [55].

In the absence of a Zeeman field, spin-orbit coupling gives a small correction to the Andreev spectrum [40,56]. Spin-orbit-induced corrections to two energy levels related by time-reversal symmetry have opposite signs. Since the total Josephson current is a summation over all time-reversed pairs of Andreev bound states, spin-orbit-induced corrections to the supercurrent are small. The main effect of spin-orbit coupling here is actually a modification to the Fermi momentum mismatch that affects normal reflection [40], thus largely indistinguishable from a small change in the Josephson junction transmission coefficient in the short-junction model.

In comparison to Ref. [17], the present work focuses on a narrower range of negative gate voltage corresponding to the few-mode regime. In this regime, we observed qualitatively similar resonant peaks followed by CPR amplitude and shape fluctuations as the number of supercurrent-carrying modes increased from one to several. Such features are not universal but depend on the geometry-induced electrostatic environment, as evidenced by our numerical modeling. The nanowire in Ref. [17] had a six-facet Al shell and a global Au bottom gate, whereas the nanowire in this work has a four-facet Al shell and a wraparound finger gate. As a result, the gate dependence of the mode structure is expected to differ quantitatively, as observed. Common to both works, as more modes are added to the junction, the CPR becomes consistently forward skewed ($S \sim 0.2$ in Ref. [17] and $S \sim 0.3$ in the present work).

The analysis of the effect of Coulomb interaction, evident from the appearance of a “shoulder” at phase $= \pi$, is consistent with the observation of “backward skewness” in Ref. [17]. When side gates are tuned to -1.5 V, the CPR evolves into a “backward-skewed” shape, where the maximum occurs at a phase $< \frac{\pi}{2}$ (Fig. S3 in [28]). The dot behavior in the present device is emergent and not gate defined. Due to the location of the side gates and screening from the epitaxial Al shell, we are unable to independently control tunnel barriers and the position of energy levels on the dot. To achieve full supercurrent reversal (as demonstrated in Ref. [53]), one needs to tune the system into a strong Coulomb blockade regime, which is difficult to do in our system.

VIII. CONCLUSION

Our measurements and analysis distinguish between a multichannel regime and a single-channel regime with widely tunable anharmonicity and interactions. Our CPR-based technique for comparing experiment and numerical simulations allows detailed study of the interplay between mode structure and electrostatics and may be extended to the design and analysis of future superconductor-semiconductor heterostructures [57].

The propensity for quantum dot formation in a nanowire-based junction, even in the absence of tunnel barrier gates, may be related to the electrostatic potential induced by the Al shell and thus must be carefully considered for Majorana measurements on superconductor-nanowire hybrids.

The presence of interactions at low electron density also has implications for experiments examining mode behavior in superconductor-nanowire hybrids, where interactions are sometimes neglected. For example, a recent work examined multiple Andreev reflections as a probe of transparency in few-mode junctions but ignored interaction effects which are known to influence IV characteristics [18,58]. Spectroscopy experiments also studied anharmonicity and Zeeman-induced spin splitting of Andreev levels in the few-mode regime but may also be affected by splitting effects from interactions as examined in our work [16,19]. Overall, our ability to accurately model device behavior, as well as to understand and control both interactions and anharmonicity, will elucidate the interpretation of current experiments and provide a method for device design.

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